OIPE JC14
NOV 19 2004
PATENT & TRADEMARK OFFICE

PTO-1449 (Modified)	ATTY. DOCKET NO.	SERIAL NUMBER
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	207.007-US	10/679,115
	APPLICANT(S) Lutz et al.	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	FILING DATE October 3, 2003	GROUP ART UNIT 3683

U.S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE
MB	6,303,512	10/2001	Laermer et al.	438	712	

FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER	DATE CONSIDERED
MB	Feb. 10, 2005

EXAMINER: Initial citation if reference was considered. Draw line through citation if not in conformance to MPEP 609 and not considered. Include copy of this form with next communication to applicant.

OIPE JC10 NOV 04 2003 PATENT & TRADEMARK OFFICE

PTO-1449 (Modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 207.007-US	SERIAL NUMBER 10/679,115
	APPLICANT(S) Lutz et al.	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	FILING DATE October 3, 2003	GROUP ART UNIT

U.S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE
[illegible]	6,318,177	11/2001	Buchan et al.	73	514.32	
[illegible]	2002/0190607	12/2002	Paden et al.	310	328	
[illegible]	2001/0017058	8/2001	Buchan et al.	73	514.32	

FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO	
[illegible]	DE 198 19 458	11/1999	Germany	—	—		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	"MEMS Resonators That Are Robust to Process-Induced Feature Width Variations", Liu et al., 2001 IEEE International Frequency Control Symposium and PDA Exhibition, July 2001, pp.556-563
	"MEMS Resonators That Are Robust to Process-Induced Feature Width Variations", Liu et al., Journal of Microelectromechanical Systems, Vol. 11, No. 5, October 2002, pp.505-511

EXAMINER [illegible]	DATE CONSIDERED Feb. 10, 2005

EXAMINER: Initial citation if reference was considered. Draw line through citation if not in conformance to MPEP 609 and not considered. Include copy of this form with next communication to applicant.

OIPE
MAY 1 6 2004
PATENT & TRADEMARK OFFICE
JC100

PTO-1449 (Modified)	ATTY. DOCKET NO.	SERIAL NUMBER
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	207.007-US	10/679,115
	APPLICANT(S) Lutz et al.	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	FILING DATE October 3, 2003	GROUP ART UNIT 3683

U.S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE
[initials]	6,318,175	11/2001	Muchow et al.	73	574.29	
[initials]	5,922,212	7/1999	Kano et al.	216	2	
[initials]	5,683,591	11/1997	Offenberg	216	2	
	5,804,083	9/1998	Ishii et al.	216	2	

FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER [initials]	DATE CONSIDERED Feb. 10, 2005

EXAMINER: Initial citation if reference was considered. Draw line through citation if not in conformance to MPEP 609 and not considered. Include copy of this form with next communication to applicant.